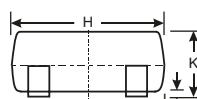
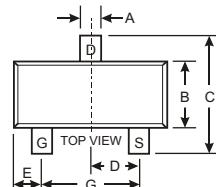


N-CHANNEL ENHANCEMENT MODE POWER MOSFET
Features

- Super high density cell design for extremely low $R_{DS(ON)}$.
- Fully characterized avalanche voltage and current.
- Excellent package for good heat dissipation.
- We declare that the material of product compliance with RoHS requirements.

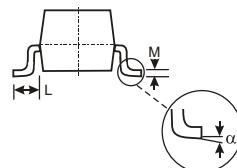


SOT-23		
Dim	Min	Max
A	0.37	0.51
B	1.20	1.40
C	2.30	2.50
D	0.89	1.03
E	0.45	0.60
G	1.78	2.05
H	2.80	3.00
J	0.013	0.10
K	0.903	1.10
L	0.45	0.61
M	0.085	0.180
α	0°	8°

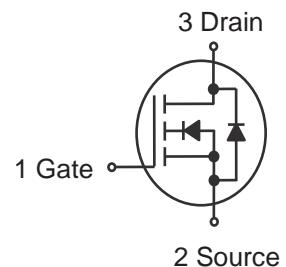
All Dimensions in mm

APPLICATIONS

- Power Switching application.
- Hard switchen and high frequency circuits.
- Uninterruptible power supply.
- Marking Code:0102.


Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current	I_D	2.0	A
Peak Drain Current ¹⁾	I_{DM}	5	A
Power Dissipation	P_{tot}	1.25	W
Thermal Resistance from Junction to Ambient (PCB mounted) ²⁾	$R_{\theta JA}$	100	°C/W
Junction Temperature	T_J	150	°C
Storage Temperature Range	T_{stg}	- 55 to + 150	°C


¹⁾ Repetitive Rating: Pulse width limited by the Maximum junction temperation.

²⁾ 1 in² 2oz Cu PCB board.



HAICHUANG SEMI

HC0102

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

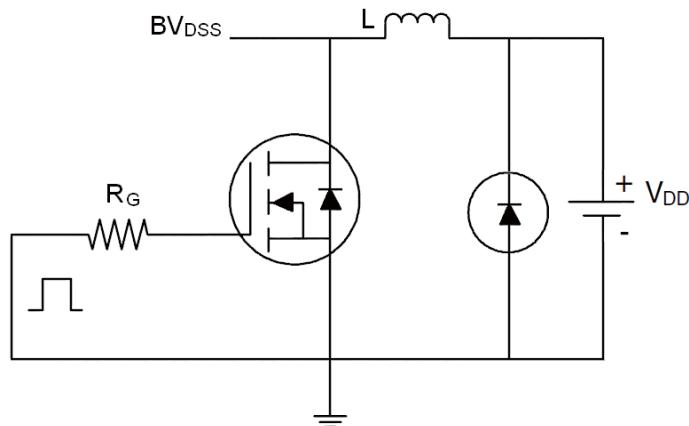
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	110	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
On Characteristics ^(Note 3)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.8	2.5	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}$	-	195	240	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=2\text{A}$	-	204	260	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=2\text{A}$	-	-	-	S
Dynamic Characteristics ^(Note 4)						
Input Capacitance	C_{iss}	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	360.6	-	PF
Output Capacitance	C_{oss}		-	24.6	-	PF
Reverse Transfer Capacitance	C_{rss}		-	13	-	PF
Switching Characteristics ^(Note 4)						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=50\text{V}, R_{\text{L}}=25\Omega, V_{\text{GS}}=10\text{V}, R_{\text{G}}=1\Omega$	-	6	-	nS
Turn-on Rise Time	t_{r}		-	10	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	12	-	nS
Turn-Off Fall Time	t_{f}		-	8	-	nS
Total Gate Charge	Q_{g}	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=2\text{A}, V_{\text{GS}}=10\text{V}$	-	12.0	-	nC
Gate-Source Charge	Q_{gs}		-	1.8	-	nC
Gate-Drain Charge	Q_{gd}		-	2.9	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage ^(Note 3)	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=2\text{A}$	-	-	1.2	V
Diode Forward Current ^(Note 2)	I_{S}		-	-	2	A

Notes:

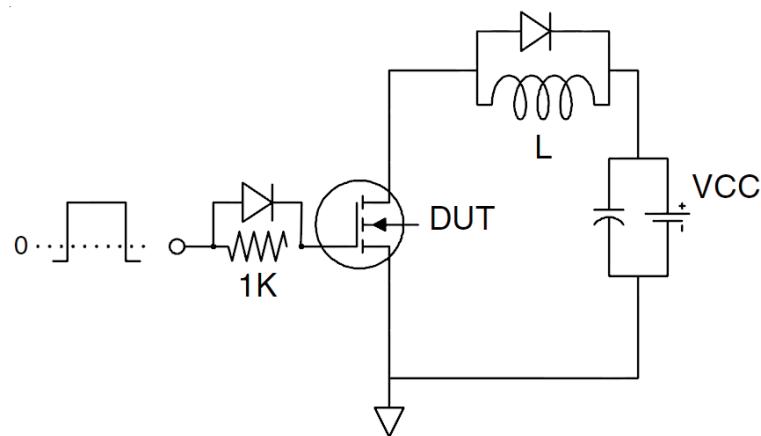
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

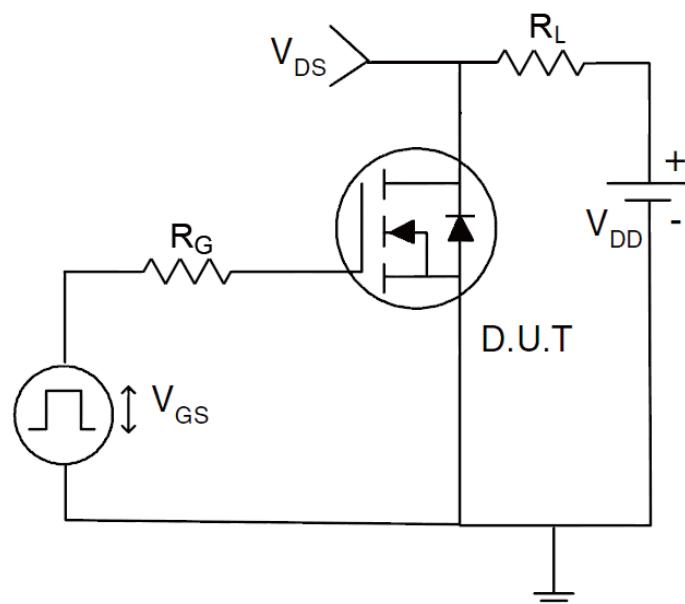
TEST CIRCUIT

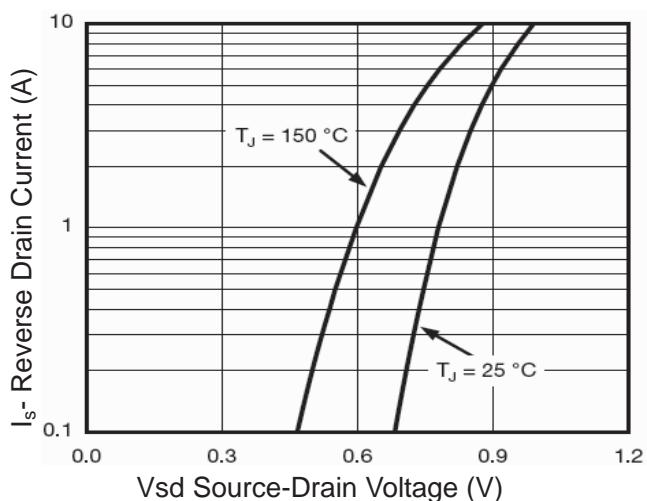
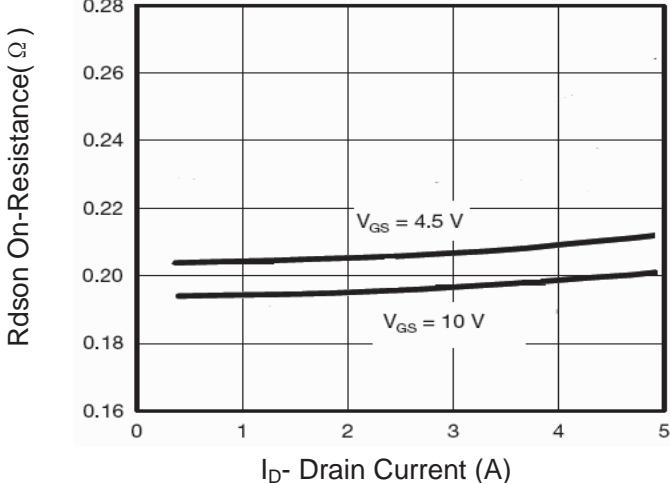
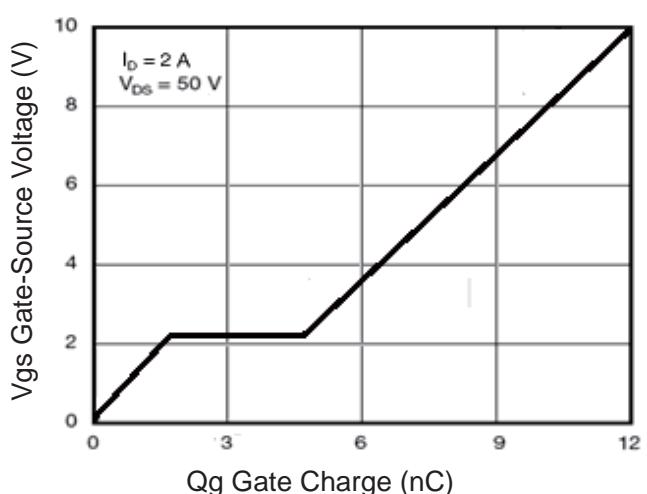
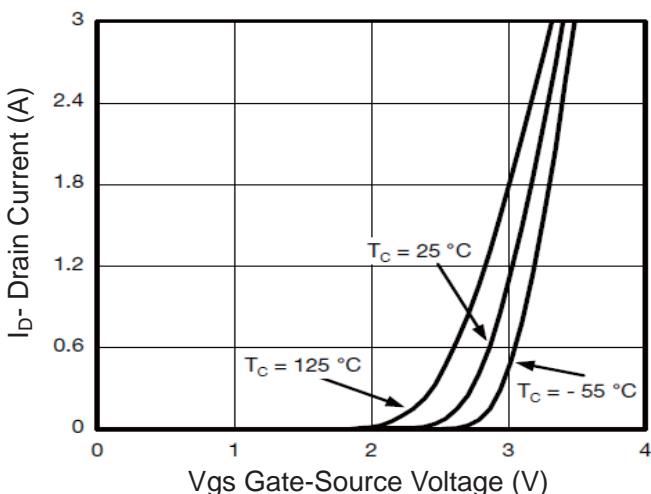
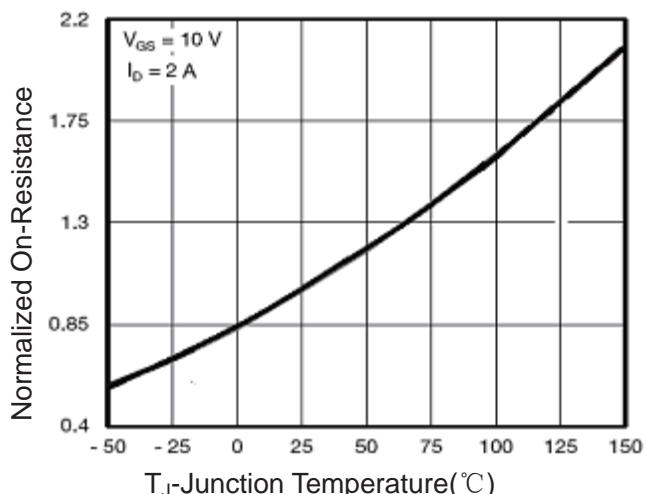
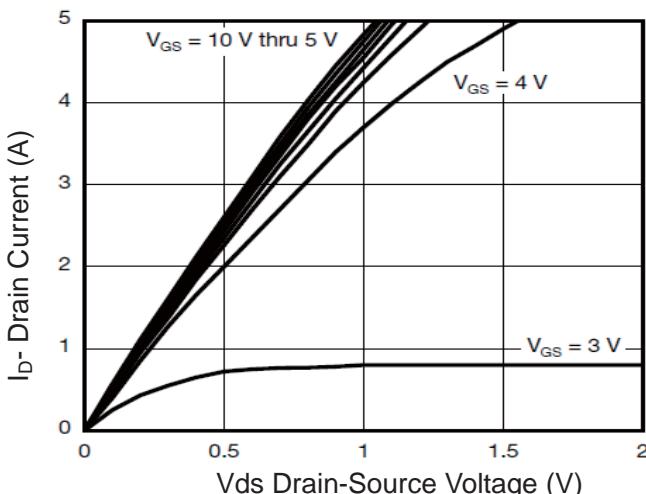
1) E_{AS} test circuit

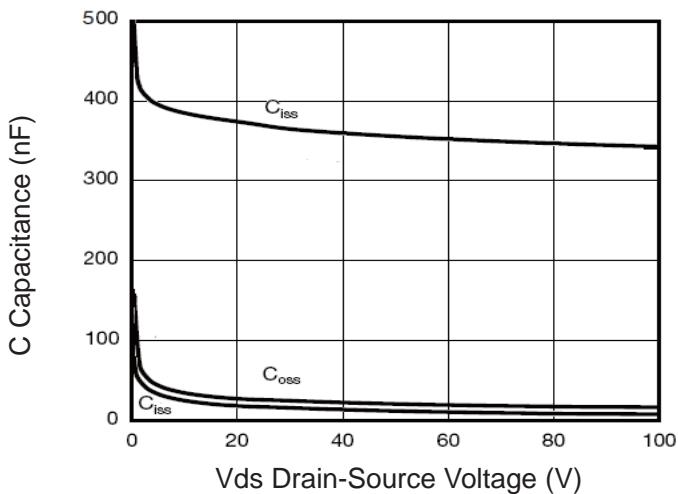
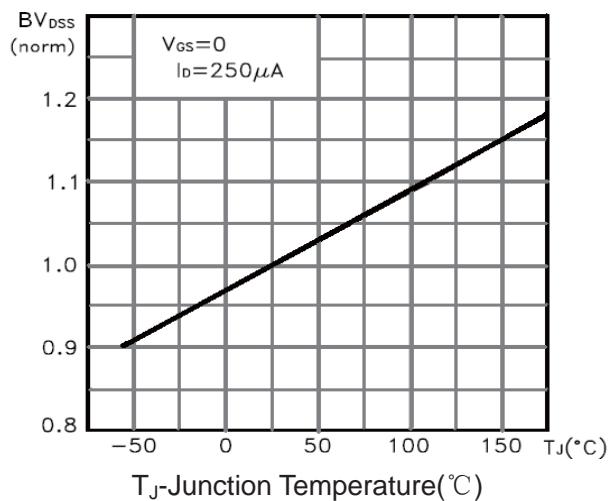
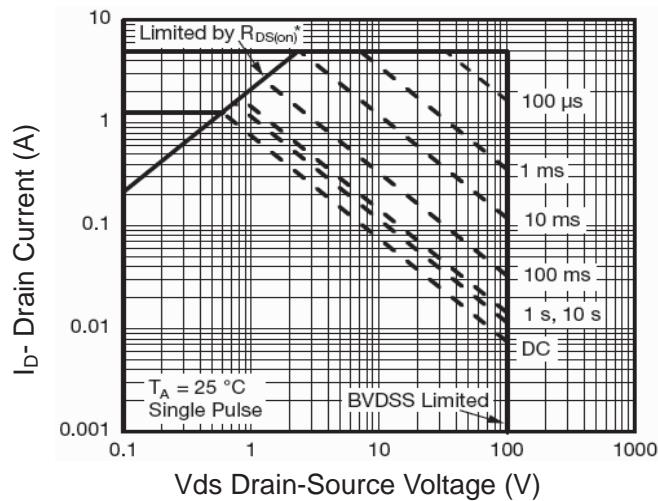
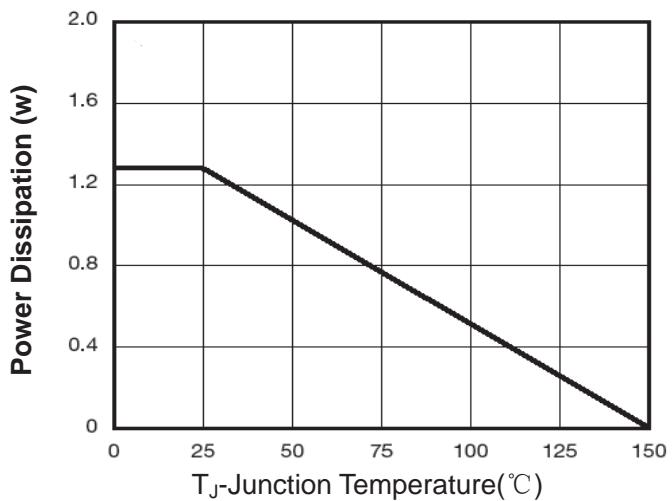
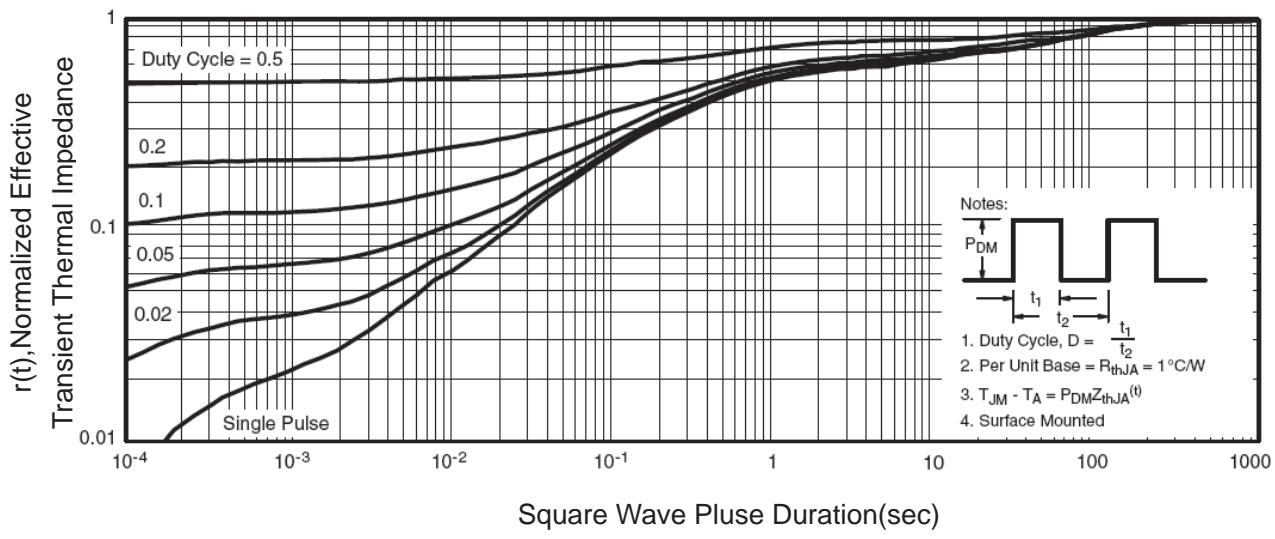
2) Gate charge test circuit



3) Switch Time Test Circuit



N-CHANNEL ENHANCEMENT MODE POWER MOSFET
TYPICAL TRANSIENT CHARACTERISTICS


TYPICAL TRANSIENT CHARACTERISTICS

Figure 7 Capacitance vs Vds

Figure 9 BV_{DSS} vs Junction Temperature

Figure 8 Safe Operation Area

Figure 10 Power De-ratin

Figure 11 Normalized Maximum Transient Thermal Impedance

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